November 1998

# FDS6875 Dual P-Channel 2.5V Specified PowerTrench<sup>™</sup> MOSFET

#### **General Description**

FAIRCHILD

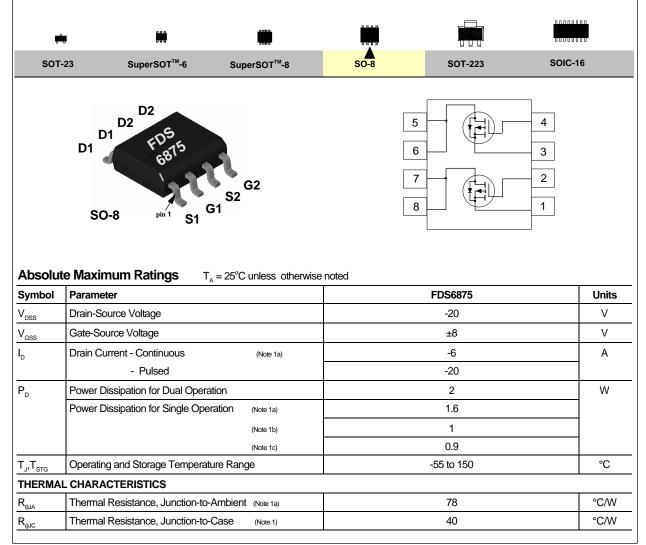
SEMICONDUCTOR IM

These P-Channel 2.5V specified MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

These devices are well suited for portable electronics applications: load switching and power management, battery charging and protection circuits.

### Features

- $\begin{array}{c|c} \bullet & -6 \text{ A}, \ -20 \text{ V}. \ \text{R}_{_{\text{DS(ON)}}} = 0.030 \ \Omega & @ \ \text{V}_{_{\text{GS}}} = -4.5 \text{ V}, \\ \text{R}_{_{\text{DS(ON)}}} = 0.040 \ \Omega & @ \ \text{V}_{_{\text{GS}}} = -2.5 \text{ V}. \end{array}$
- Low gate charge (23nC typical).
- High performance trench technology for extremely low R<sub>DS(ON)</sub>.
- High power and current handling capability.

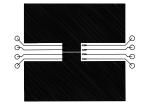


© 1998 Fairchild Semiconductor Corporation

Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHAF	ACTERISTICS					•	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = -250 \mu A$		-20			V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temp. Coefficient	$I_{\rm D}$ = -250 µA, Referenced to	o 25 ℃		-21		mV/ºC
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -16 V, V_{GS} = 0 V$				-1	μA
			T <sub>J</sub> = 55°C			-10	μA
GSSF	Gate - Body Leakage, Forward	$V_{GS} = 8 V, V_{DS} = 0 V$				100	nA
GSSR	Gate - Body Leakage, Reverse	$V_{GS} = -8 V, V_{DS} = 0 V$				-100	nA
	CTERISTICS (Note 2)						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$		-0.4	-0.8	-1.5	V
$\Delta V_{GS(th)} / \Delta T_{J}$	Gate Threshold Voltage Temp. Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25 ^{\circ}\text{C}$			2.8		mV/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -4.5 \text{ V}, I_{D} = -6 \text{ A}$			0.024	0.03	Ω
()			T_ =125°C		0.033	0.048	
		$V_{GS} = -2.5 \text{ V}, I_{D} = -5.3 \text{ A}$			0.032	0.04	
l <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$		-20			А
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = -4.5 \text{ V}, I_{D} = -6 \text{ A}$			22		S
DYNAMIC	CHARACTERISTICS	•					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			2250		pF
C <sub>oss</sub>	Output Capacitance				500		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				200		pF
SWITCHING	G CHARACTERISTICS (Note 2)						
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DS}$ = -10 V, $I_{D}$ = -1 A			8	16	ns
t,	Turn - On Rise Time	$V_{\text{gen}}$ = -4.5 V, $R_{\text{gen}}$ = 6 $\Omega$			15	27	ns
t <sub>D(off)</sub>	Turn - Off Delay Time				98	135	ns
t <sub>r</sub>	Turn - Off Fall Time				35	55	ns
Q	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -6 \text{ A},$			23	31	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = -5 V			3.9		nC
Q <sub>gd</sub>	Gate-Drain Charge				5.5		nC
DRAIN-SO	JRCE DIODE CHARACTERISTICS AND MAX	IMUM RATINGS					
l <sub>s</sub>	Maximum Continuous Drain-Source Diode Forward Current					-1.3	А
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = -1.3 A$ (Note 2)			-0.7	-1.2	V

Notes:

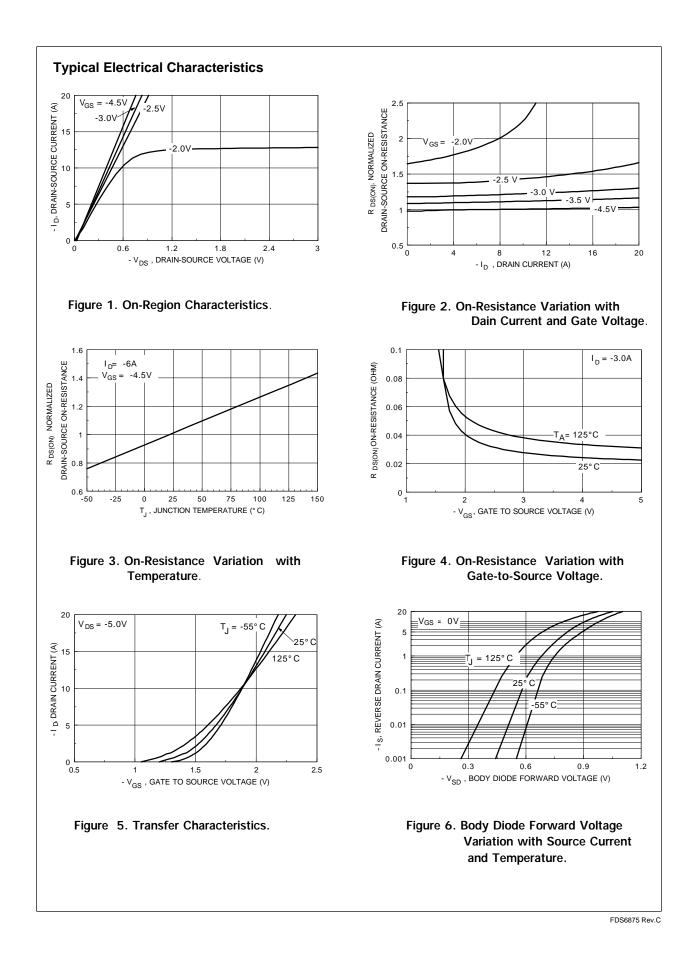
1. R<sub>BW</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>BW</sub> is guaranteed by design while R<sub>BW</sub> is determined by the user's board design.

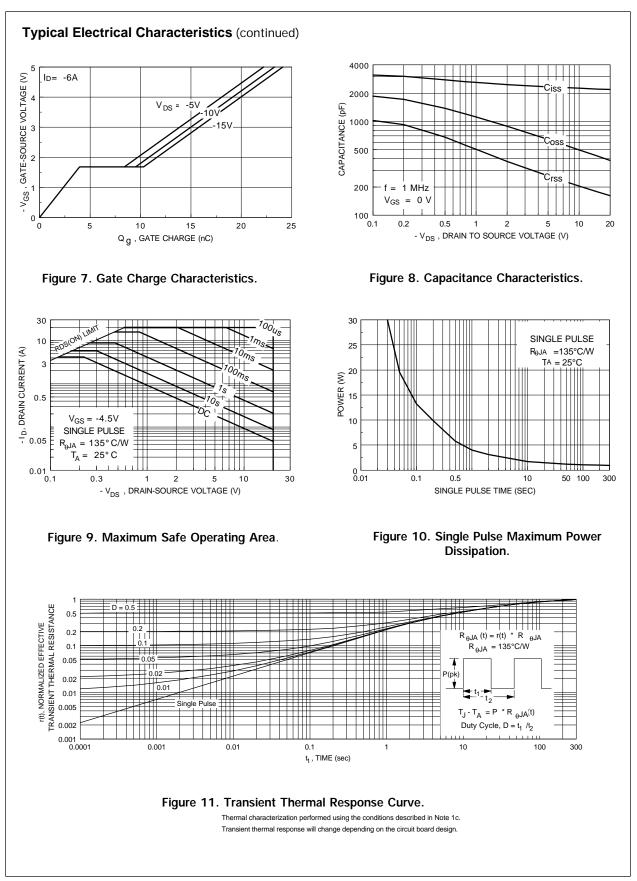


a. 78°C/W on a 0.5 in<sup>2</sup> pad of 2oz copper. b. 125°C/W on a 0.02 in<sup>2</sup> pad of 2oz copper. c. 135°C/W on a 0.003 in<sup>2</sup> pad of 2oz copper.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2.0%.





#### TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx<sup>TM</sup> CoolFET<sup>TM</sup> CROSSVOLT<sup>TM</sup> E<sup>2</sup>CMOS<sup>TM</sup> FACT<sup>TM</sup> FACT Quiet Series<sup>TM</sup> FAST<sup>®</sup> FAST<sup>®</sup> FASTr<sup>TM</sup> GTO<sup>TM</sup> HiSeC<sup>TM</sup> ISOPLANAR<sup>™</sup> MICROWIRE<sup>™</sup> POP<sup>™</sup> PowerTrench<sup>™</sup> QFET<sup>™</sup> QS<sup>™</sup> Quiet Series<sup>™</sup> SuperSOT<sup>™</sup>-3 SuperSOT<sup>™</sup>-6 SuperSOT<sup>™</sup>-8

TinyLogic™ UHC™ VCX™

## DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user. 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

# **Mouser Electronics**

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Fairchild Semiconductor: <u>FDS6875</u>